

APPROVAL SHEET

| Approval Specification | Customer's Approval Certificate |
|------------------------|---|
| TO: | Checked & Approved by: |
| Part No.: | Date: |
| Customer's Part No.: | Please return this copy as a certification of your approval |

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| | | |
|----------|---|----------|
| Part No. | : | R370 |
| Pages | : | 4 |
| Date | : | 2016/8/1 |
| Revision | : | 2.0 |

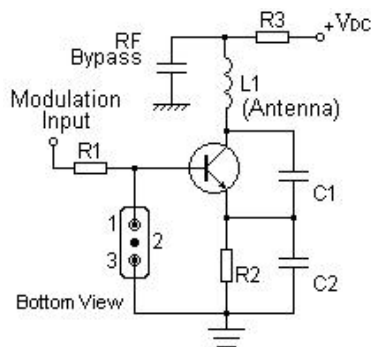
Features

- 1-port Resonator
- Metal Case for **D11**
- Package size 8.36x3.45x3.00 mm³
- **RoHS** compatible
- **Electrostatic Sensitive Device(ESD)**

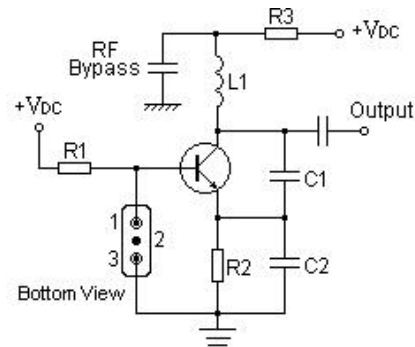


Application

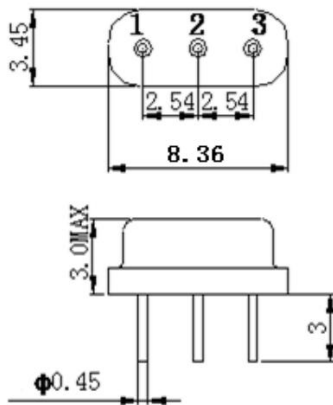
Typical Low-Power Transmitter Application



Typical Local Oscillator Application



Package Dimensions (D11)



Pin Configuration

| | |
|---|--------------|
| 1 | Input/Output |
| 3 | Output/Input |
| 2 | Case Ground |

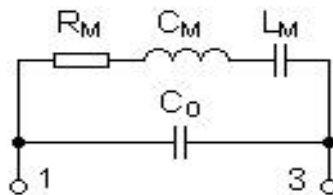
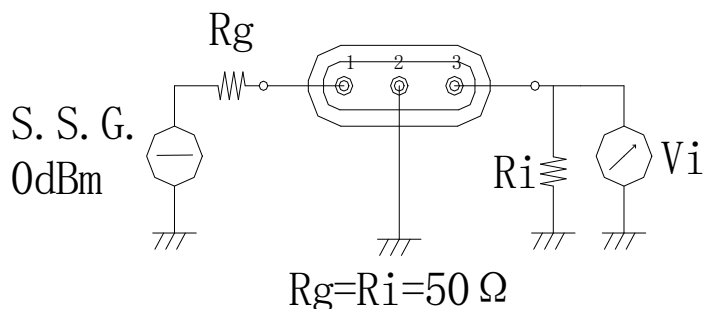
Marking



| | |
|-----|---------------|
| R | SAW Resonator |
| 370 | Part number |

Test Circuit

Equivalent LC Model



Performance

Maximum Rating

| Item | | Value | Unit |
|-----------------------|-----------|-----------|--------------------|
| DC Voltage | V_{DC} | ± 30 | V |
| Operation Temperature | T | -40 ~ +85 | $^{\circ}\text{C}$ |
| Storage Temperature | T_{stg} | -40 ~ +85 | $^{\circ}\text{C}$ |
| RF Power Dissipation | P | 25 | dBm |

Electronic Characteristics

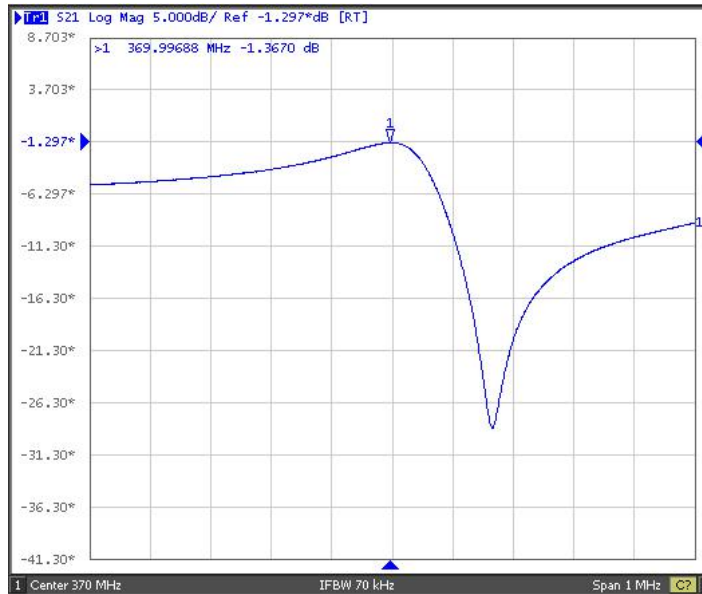
Test Temperature: $25^{\circ}\text{C} \pm 2^{\circ}\text{C}$

Terminating source impedance: $50\ \Omega$

Terminating load impedance: $50\ \Omega$

| Item | | Minimum | Typical | Maximum | Unit |
|---|--------------------------------------|--------------|-----------|---------|---------------|
| Center Frequency | Absolute Frequency | f_c | 370.00 | | MHz |
| | Tolerance from 370.00MHz | Δf_c | ± 75 | | KHz |
| Insertion Loss(min) | IL | | 1.4 | 2.0 | dB |
| Quality Factor | Unloaded Q | Q_U | 17803 | | |
| | 50 Ω Loaded Q | Q_L | 2119 | | |
| Frequency Aging | Absolute Value during the First Year | $ f_A $ | ≤ 10 | | ppm/yr |
| DC Insulation Resistance between Any Two Pins | | 1.0 | | | M Ω |
| RF Equivalent RLC Model | Motional Resistance | R_M | 13.5 | 18.0 | Ω |
| | Motional Inductance | L_M | 103.5 | | μH |
| | Motional Capacitance | C_M | 1.78 | | fF |
| | Static Capacitance | C_0 | 2.0 | 2.2 | 2.4 |

Frequency Response



Reliability (The SAW components shall remain electrical performance after tests)

| No. | Test item | Test condition |
|-----|------------------------------|--|
| 1 | Temperature Storage | (1) Temperature: $85^{\circ}\text{C}\pm 2^{\circ}\text{C}$, Duration: 250h , Recovery time: $2\text{h}\pm 0.5\text{h}$ (2) Temperature: $-40^{\circ}\text{C}\pm 3^{\circ}\text{C}$, Duration: 250h , Recovery time: $2\text{h}\pm 0.5\text{h}$ |
| 2 | Humidity Test | Conditions: $60^{\circ}\text{C}\pm 2^{\circ}\text{C}$, 90~95% RH Duration: 250h |
| 3 | Thermal Shock | Heat cycle conditions: $\text{TA}=-40^{\circ}\text{C}\pm 3^{\circ}\text{C}$, $\text{TB}=85^{\circ}\text{C}\pm 2^{\circ}\text{C}$, $t_1=t_2=30\text{min}$, Switch time: $\leq 3\text{min}$, Cycle time: 100 times , Recovery time : $2\text{h}\pm 0.5\text{h}$. |
| 4 | Vibration Fatigue | Frequency of vibration: 10~55Hz Amplitude: 1.5mm Directions: X,Y and Z Duration: 2h |
| 5 | Drop Test | Cycle time: 10 times Height: 1.0m |
| 6 | Solder Ability Test | Temperature: $245^{\circ}\text{C}\pm 5^{\circ}\text{C}$ Duration: 3.0s--5.0s Depth: DIP--2/3 , SMD--1/5 |
| 7 | Resistance to Soldering Heat | (1) Thickness of PCB: 1mm , Solder condition: $260^{\circ}\text{C}\pm 5^{\circ}\text{C}$, Duration: $10\pm 1\text{s}$ (2) Temperature of Soldering Iron: $350^{\circ}\text{C}\pm 10^{\circ}\text{C}$, Duration: 3~4s , Recovery time : $2 \pm 0.5\text{h}$ |

Notes

- As a result of the particularity of inner structure of SAW products, it easy to be breakdown by electrostatic, so we should pay attention to **ESD protect** in the test.
- Static voltage** between signal load and ground may cause deterioration and destruction of the component. Please avoid static voltage.
- Ultrasonic cleaning** may cause deterioration and destruction of the component. Please avoid ultrasonic cleaning.
- Only leads of component may **be soldered**. Please avoid soldering another part of component.
- There is a close relationship between the device's performance and **matching network**. The specifications of this device are based on the test circuit shown above. L and C values may change depending on board layout. Values shown are intended as a guide only.